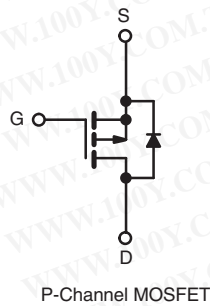
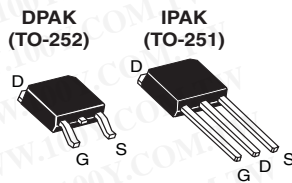


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## Power MOSFET

PRODUCT SUMMARY		
$V_{DS}$ (V)	- 50	
$R_{DS(on)}$ ( $\Omega$ )	$V_{GS} = - 10$ V	0.50
$Q_g$ (Max.) (nC)	9.1	
$Q_{gs}$ (nC)	3.0	
$Q_{gd}$ (nC)	5.9	
Configuration	Single	



### FEATURES

- Halogen-free According to IEC 61249-2-21 Definition
- Surface Mountable (Order as IRFR9010, SiHFR9010)
- Straight Lead Option (Order as IRFU9010, SiHFU9010)
- Repetitive Avalanche Ratings
- Dynamic  $dV/dt$  Rating
- Simple Drive Requirements
- Ease of Paralleling
- Compliant to RoHS Directive 2002/95/EC



### DESCRIPTION

The Power MOSFET technology is the key to Vishay's advanced line of Power MOSFET transistors. The efficient geometry and unique processing of this latest "State of the Art" design achieves: very low on-state resistance combined with high transconductance; superior reverse energy and diode recovery  $dV/dt$  capability.

The Power MOSFET transistors also feature all of the well established advantages of MOSFETs such as voltage control, very fast switching, ease of paralleling and temperature stability of the electrical parameters.

Surface mount packages enhance circuit performance by reducing stray inductances and capacitance. The DPAK (TO-252) surface mount package brings the advantages of Power MOSFETs to high volume applications where PC Board surface mounting is desirable. The surface mount option IRFR9010, SiHFR9010 is provided on 16 mm tape. The straight lead option IRFU9010, SiHFU9010 of the device is called the IPAK (TO-251).

They are well suited for applications where limited heat dissipation is required such as, computers and peripherals, telecommunication equipment, dc-to-dc converters, and a wide range of consumer products.

ORDERING INFORMATION				
Package	DPAK (TO-252)	DPAK (TO-252)	DPAK (TO-252)	IPAK (TO-251)
Lead (Pb)-free and Halogen-free	SiHFR9010-GE3	SiHFR9010TR-GE3 <sup>a</sup>	SiHFR9010TRL-GE3 <sup>a</sup>	SiHFU9010-GE3
Lead (Pb)-free	IRFR9010PbF	IRFR9010TRPbF <sup>a</sup>	IRFR9010TRLPbF <sup>a</sup>	IRFU9010PbF
	SiHFR9010-E3	SiHFR9010T-E3 <sup>a</sup>	SiHFR9010TL-E3 <sup>a</sup>	SiHFU9010-E3
SnPb	IRFR9010	IRFR9010TR <sup>a</sup>	IRFR9010TRL <sup>a</sup>	IRFU9010
	SiHFR9010	SiHFR9010T <sup>a</sup>	SiHFR9010TL <sup>a</sup>	SiHFU9010

#### Note

a. See device orientation.

ABSOLUTE MAXIMUM RATINGS $T_C = 25^\circ\text{C}$ , unless otherwise noted					
PARAMETER			SYMBOL	LIMIT	UNIT
Drain-Source Voltage			$V_{DS}$	- 50	V
Gate-Source Voltage			$V_{GS}$	$\pm 20$	
Continuous Drain Current	$V_{GS}$ at - 10 V	$T_C = 25^\circ\text{C}$	$I_D$	- 5.3	A
		$T_C = 100^\circ\text{C}$		- 3.3	
Pulsed Drain Current <sup>a</sup>			$I_{DM}$	- 21	
Linear Derating Factor				0.20	W/ $^\circ\text{C}$
Single Pulse Avalanche Energy <sup>b</sup>			$E_{AS}$	136	mJ
Repetitive Avalanche Current <sup>a</sup>			$I_{AR}$	- 5.3	A
Repetitive Avalanche Energy <sup>a</sup>			$E_{AR}$	2.5	mJ
Maximum Power Dissipation	$T_C = 25^\circ\text{C}$		$P_D$	25	W
Peak Diode Recovery $dV/dt^c$			$dV/dt$	5.8	V/ns
Operating Junction and Storage Temperature Range			$T_J, T_{stg}$	- 55 to + 150	$^\circ\text{C}$
Soldering Recommendations (Peak Temperature) <sup>d</sup>	for 10 s			300	

#### Notes



- Repetitive rating; pulse width limited by maximum junction temperature (see fig. 14).
- $V_{DD} = - 25$  V, starting  $T_J = 25^\circ\text{C}$ ,  $L = 9.7$  mH,  $R_g = 25 \Omega$ , peak  $I_L = - 5.3$  A.
- $I_{sp} \leq - 5.3$  A,  $dI/dt \leq - 80$  A/ $\mu\text{s}$ ,  $V_{DD} \leq 40$  V,  $T_J \leq 150^\circ\text{C}$ , suggested  $R_g = 24 \Omega$ .
- 0.063" (1.6 mm) from case.

\* Pb containing terminations are not RoHS compliant, exemptions may apply

THERMAL RESISTANCE RATINGS					
PARAMETER	SYMBOL	MIN.	TYP.	MAX.	UNIT
Maximum Junction-to-Ambient	$R_{thJA}$	-	-	110	°C/W
Case-to-Sink	$R_{thCS}$	-	1.7	-	
Maximum Junction-to-Case (Drain) <sup>a</sup>	$R_{thJC}$	-	-	5.0	

**Note**

a. Mounting pad must cover heatsink surface area.

SPECIFICATIONS $T_J = 25\text{ }^\circ\text{C}$ , unless otherwise noted							
PARAMETER	SYMBOL	TEST CONDITIONS		MIN.	TYP.	MAX.	UNIT
<b>Static</b>							
Drain-Source Breakdown Voltage	$V_{DS}$	$V_{GS} = 0\text{ V}, I_D = -250\text{ }\mu\text{A}$		- 50	-	-	V
Gate-Source Threshold Voltage	$V_{GS(th)}$	$V_{DS} = V_{GS}, I_D = -250\text{ }\mu\text{A}$		- 2.0	-	- 4.0	V
Gate-Source Leakage	$I_{GSS}$	$V_{GS} = \pm 20\text{ V}$		-	-	$\pm 500$	nA
Zero Gate Voltage Drain Current	$I_{DSS}$	$V_{DS} = \text{max. rating}, V_{GS} = 0\text{ V}$		-	-	- 250	$\mu\text{A}$
		$V_{DS} = 0.8 \times \text{max. rating}, V_{GS} = 0\text{ V}, T_J = 125\text{ }^\circ\text{C}$		-	-	- 1000	
Drain-Source On-State Resistance	$R_{DS(on)}$	$V_{GS} = -10\text{ V}$	$I_D = -2.8\text{ A}^b$	-	0.35	0.5	$\Omega$
Forward Transconductance	$g_{fs}$	$V_{DS} \leq -50\text{ V}, I_{DS} = -2.8\text{ A}$		1.1	1.7	-	S
<b>Dynamic</b>							
Input Capacitance	$C_{iss}$	$V_{GS} = 0\text{ V}, V_{DS} = -25\text{ V}, f = 1.0\text{ MHz}$ , see fig. 9		-	240	-	pF
Output Capacitance	$C_{oss}$			-	160	-	
Reverse Transfer Capacitance	$C_{rss}$			-	30	-	
Total Gate Charge	$Q_g$	$V_{GS} = -10\text{ V}$	$I_D = -4.7\text{ A}, V_{DS} = 0.8 \times \text{max. rating}$ , see fig. 16 (Independent operating temperature)	-	6.1	9.1	nC
Gate-Source Charge	$Q_{gs}$			-	2.0	3.0	
Gate-Drain Charge	$Q_{gd}$			-	3.9	5.9	
Turn-On Delay Time	$t_{d(on)}$	$V_{DD} = -25\text{ V}, I_D = -4.7\text{ A}, R_g = 24\text{ }\Omega, R_D = 5.6\text{ }\Omega$ , see fig. 15 (Independent operating temperature)		-	6.1	9.2	ns
Rise Time	$t_r$			-	47	71	
Turn-Off Delay Time	$t_{d(off)}$			-	13	20	
Fall Time	$t_f$			-	35	59	
Internal Drain Inductance	$L_D$	Between lead, 6 mm (0.25") from package and center of die contact. 		-	4.5	-	nH
Internal Source Inductance	$L_S$			-	7.5	-	
<b>Drain-Source Body Diode Characteristics</b>							
Continuous Source-Drain Diode Current	$I_S$	MOSFET symbol showing the integral reverse p - n junction diode 		-	-	- 5.3	A
Pulsed Diode Forward Current <sup>a</sup>	$I_{SM}$			-	-	- 18	
Body Diode Voltage	$V_{SD}$	$T_J = 25\text{ }^\circ\text{C}, I_S = -5.3\text{ A}, V_{GS} = 0\text{ V}^b$		-	-	- 5.5	V
Body Diode Reverse Recovery Time	$t_{rr}$	$T_J = 25\text{ }^\circ\text{C}, I_F = -4.7\text{ A}, dI/dt = 100\text{ A}/\mu\text{s}^b$		33	75	160	ns
Body Diode Reverse Recovery Charge	$Q_{rr}$			0.090	0.22	0.52	$\mu\text{C}$
Forward Turn-On Time	$t_{on}$	Intrinsic turn-on time is negligible (turn-on is dominated by $L_S$ and $L_D$ )					

**Notes**

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 14).
- b. Pulse width  $\leq 300\text{ }\mu\text{s}$ ; duty cycle  $\leq 2\%$ .

## TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted

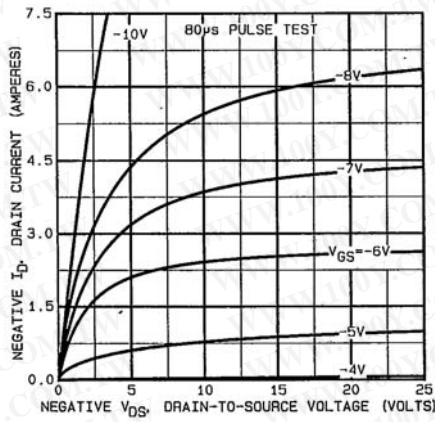


Fig. 1 - Typical Output Characteristics

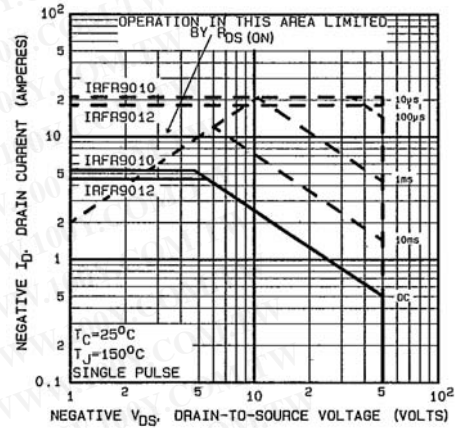


Fig. 4 - Maximum Safe Operating Area

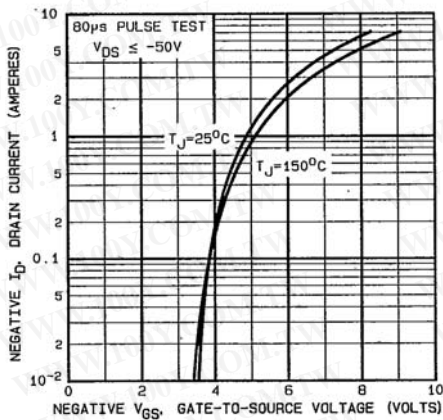


Fig. 2 - Typical Transfer Characteristics

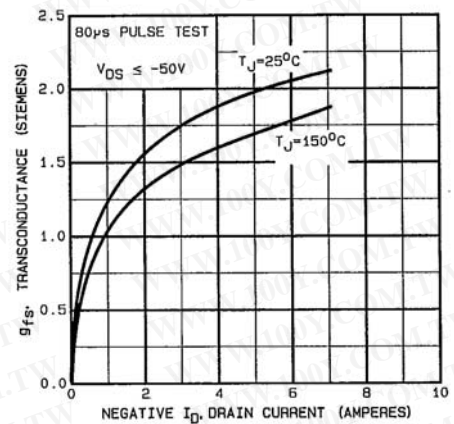


Fig. 5 - Typical Transconductance vs. Drain Current

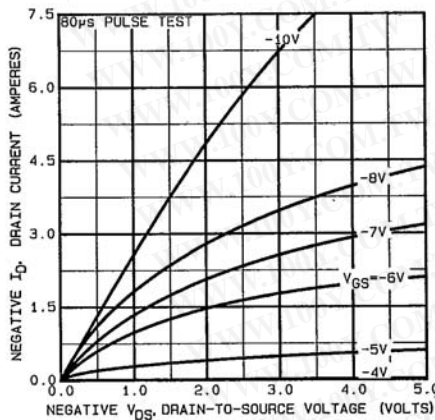


Fig. 3 - Typical Saturation Characteristics

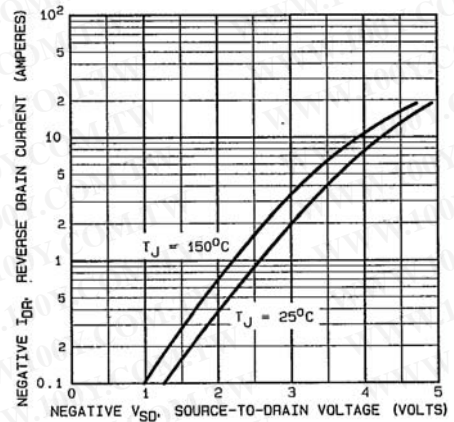


Fig. 6 - Typical Source-Drain Diode Forward Voltage

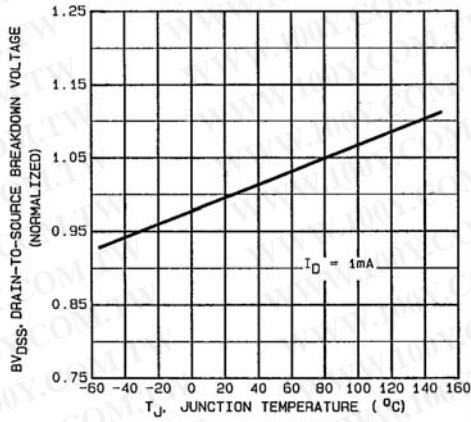


Fig. 7 - Breakdown Voltage vs. Temperature

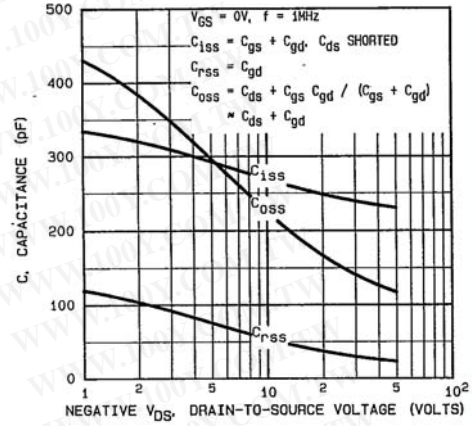


Fig. 9 - Typical Capacitance vs. Drain-to-Source Voltage

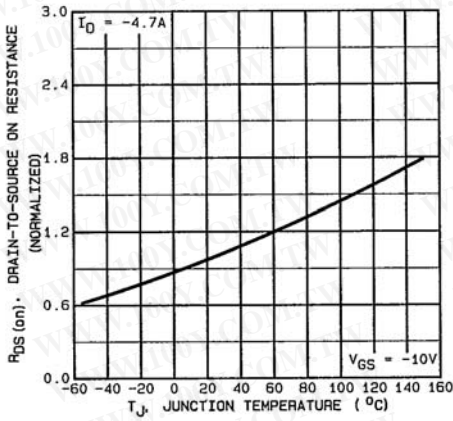


Fig. 8 - Normalized On-Resistance vs. Temperature

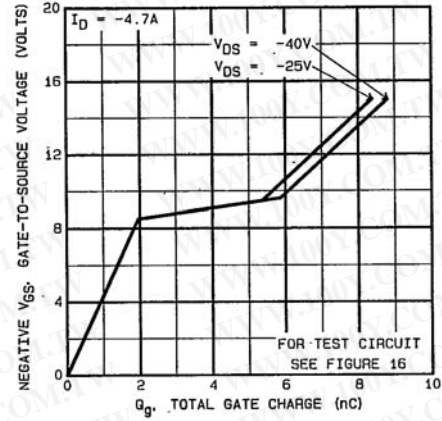


Fig. 10 - Typical Gate Charge vs. Gate-to-Source Voltage

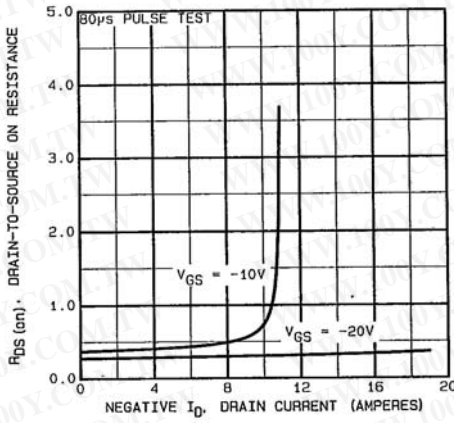


Fig. 11 - Typical On-Resistance vs. Drain Current

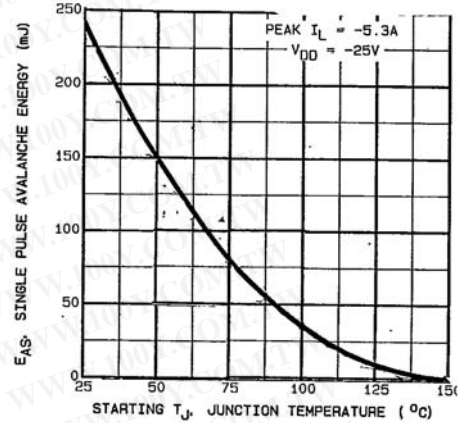


Fig. 13a - Maximum Avalanche vs. Starting Junction Temperature

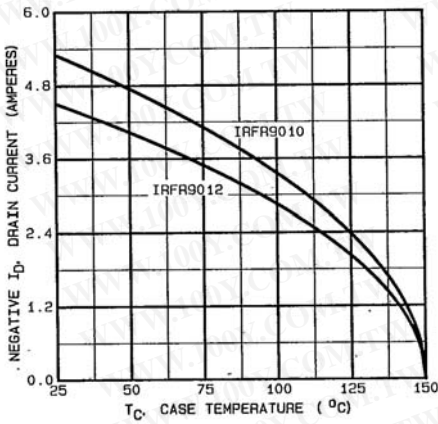


Fig. 12 - Maximum Drain Current vs. Case Temperature

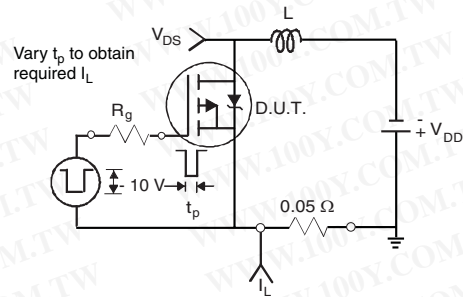


Fig. 13b - Unclamped Inductive Test Circuit

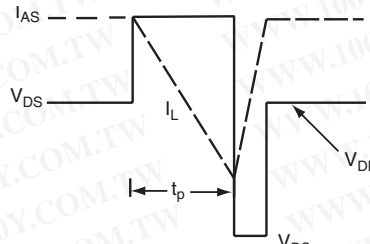


Fig. 13c - Unclamped Inductive Waveforms

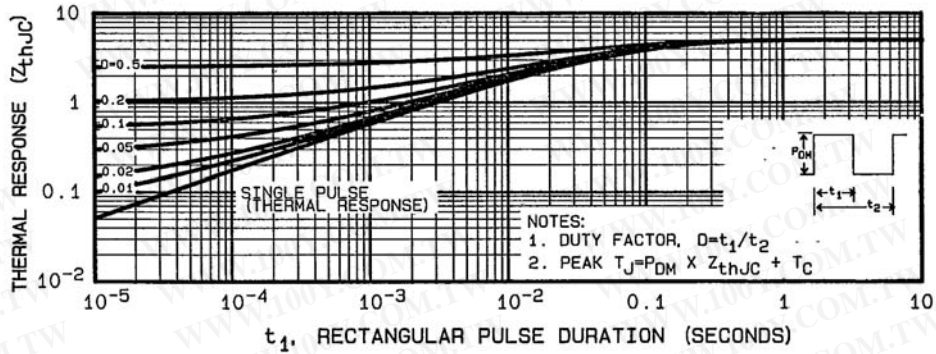


Fig. 14 - Maximum Effective Transient Thermal Impedance, Junction-to-Case vs. Pulse Duration

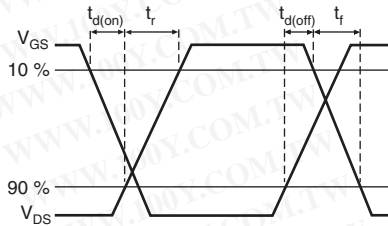


Fig. 15a - Switching Time Waveforms

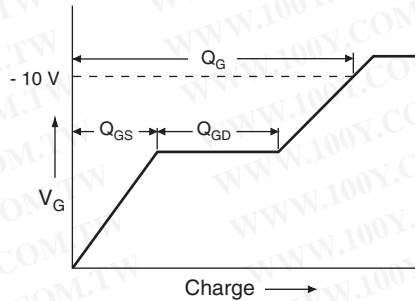


Fig. 16a - Basic Gate Charge Waveform

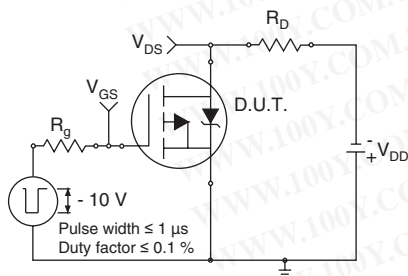


Fig. 15b - Switching Time Test Circuit

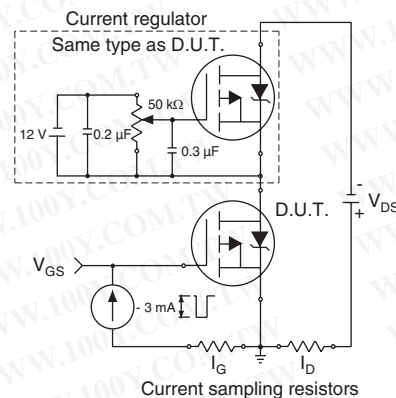
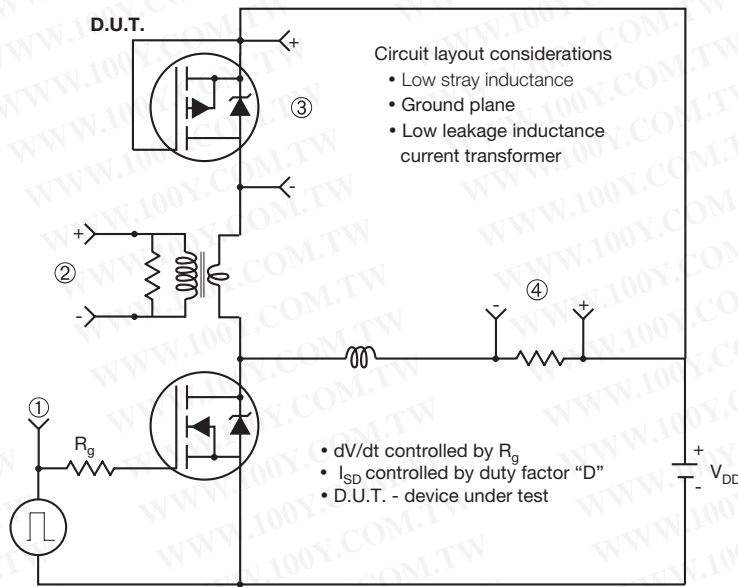
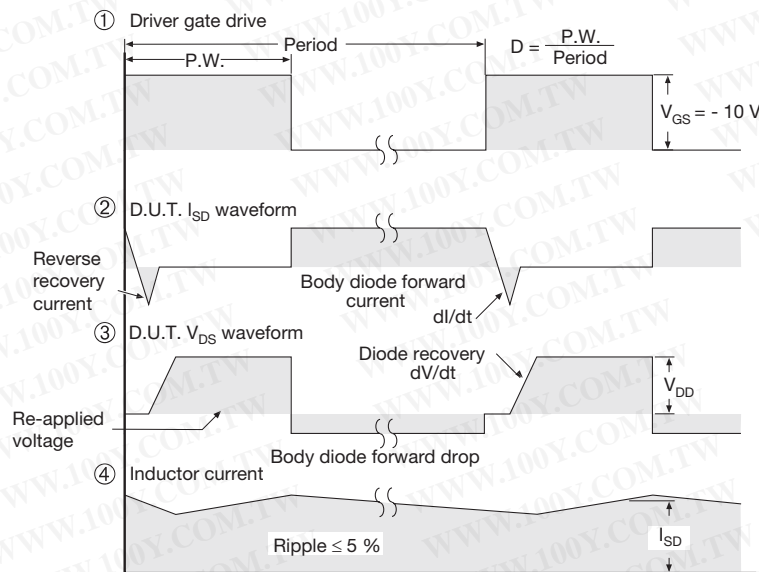


Fig. 16b - Gate Charge Test Circuit

### Peak Diode Recovery dV/dt Test Circuit



**Note**  
 • Compliment N-Channel of D.U.T. for driver



**Note**  
 a.  $V_{GS} = -5\text{ V}$  for logic level and  $-3\text{ V}$  drive devices

**Fig. 17 - For P-Channel**

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